

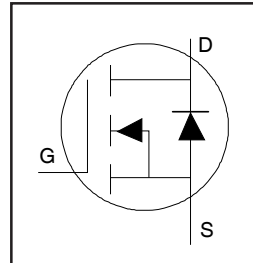
# Strong *IR*FET™ IRFB7446PbF

## Applications

- Brushed Motor drive applications
- BLDC Motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC Inverters

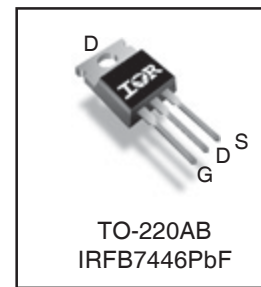
## Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free



## HEXFET® Power MOSFET

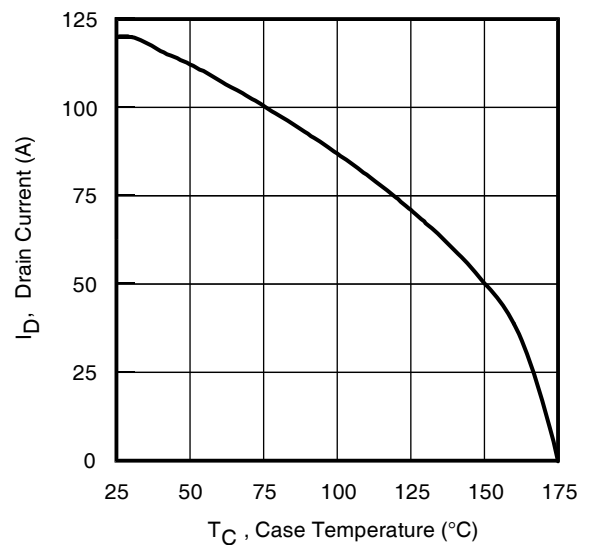
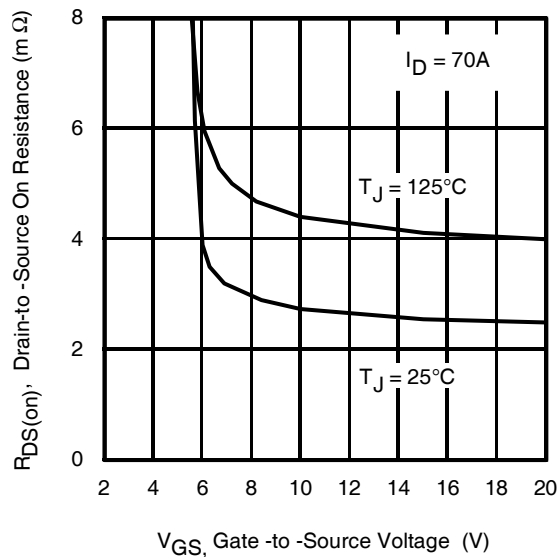
|                          |               |
|--------------------------|---------------|
| $V_{DSS}$                | <b>40V</b>    |
| $R_{DS(on)}$ <b>typ.</b> | <b>2.6mΩ</b>  |
|                          | <b>max.</b>   |
| $I_D$ (Silicon Limited)  | <b>123A</b> ① |
| $I_D$ (Package Limited)  | <b>120A</b>   |



|          |          |          |
|----------|----------|----------|
| <b>G</b> | <b>D</b> | <b>S</b> |
| Gate     | Drain    | Source   |

## Ordering Information

| Base part number | Package Type | Standard Pack |          | Complete Part Number |
|------------------|--------------|---------------|----------|----------------------|
|                  |              | Form          | Quantity |                      |
| IRFB7446PbF      | TO-220       | Tube          | 50       | IRFB7446PbF          |



**Fig 1.** Typical On-Resistance vs. Gate Voltage

**Fig 2.** Maximum Drain Current vs. Case Temperature

**Absolute Maximum Ratings**

| Symbol                          | Parameter   | Max.              | Units |
|---------------------------------|---|-------------------|-------|
| $I_D @ T_C = 25^\circ\text{C}$  | Continuous Drain Current, $V_{GS} @ 10\text{V}$ (Silicon Limited)   | 123 <sup>①</sup>  | A     |
| $I_D @ T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10\text{V}$ (Silicon Limited)   | 87                |       |
| $I_D @ T_C = 25^\circ\text{C}$  | Continuous Drain Current, $V_{GS} @ 10\text{V}$ (Wire Bond Limited) | 120               |       |
| $I_{DM}$                        | Pulsed Drain Current <sup>②</sup>                                   | 492               |       |
| $P_D @ T_C = 25^\circ\text{C}$  | Maximum Power Dissipation   | 99                | W     |
|                                 | Linear Derating Factor  | 0.66              | W/°C  |
| $V_{GS}$                        | Gate-to-Source Voltage  | $\pm 20$          | V     |
| $T_J$                           | Operating Junction and  | -55 to + 175      | °C    |
| $T_{STG}$                       | Storage Temperature Range   |                   |       |
|                                 | Soldering Temperature, for 10 seconds (1.6mm from case)             | 300               |       |
|                                 | Mounting torque, 6-32 or M3 screw                                   | 10lbf·in (1.1N·m) |       |

**Avalanche Characteristics**

|                              |   |                           |    |
|------------------------------|---|---------------------------|----|
| $E_{AS}$ (Thermally limited) | Single Pulse Avalanche Energy <sup>③</sup>              | 111                       | mJ |
| $E_{AS}$ (tested)            | Single Pulse Avalanche Energy Tested Value <sup>④</sup> | 160                       |    |
| $I_{AR}$                     | Avalanche Current <sup>②</sup>                          | See Fig. 14, 15, 22a, 22b | A  |
| $E_{AR}$                     | Repetitive Avalanche Energy <sup>②</sup>                |                           | mJ |

**Thermal Resistance**

| Symbol          | Parameter                          | Typ. | Max. | Units |
|-----------------|------------------------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case <sup>⑤</sup>      | —    | 1.52 | °C/W  |
| $R_{\theta CS}$ | Case-to-Sink, Flat Greased Surface | 0.50 | —    |       |
| $R_{\theta JA}$ | Junction-to-Ambient                | —    | 62   |       |

**Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

| Symbol                          | Parameter                            | Min. | Typ.  | Max. | Units | Conditions   |
|---------------------------------|--------------------------------------|------|-------|------|-------|--|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 40   | —     | —    | V     | $V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$                         |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.033 | —    | V/°C  | Reference to $25^\circ\text{C}, I_D = 5\text{mA}$ <sup>⑥</sup>     |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | 2.6   | 3.3  | mΩ    | $V_{GS} = 10\text{V}, I_D = 70\text{A}$ <sup>⑦</sup>               |
|                                 |                                      | —    | 3.9   | —    | mΩ    | $V_{GS} = 6.0\text{V}, I_D = 35\text{A}$ <sup>⑦</sup>              |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.2  | 3.0   | 3.9  | V     | $V_{DS} = V_{GS}, I_D = 100\mu\text{A}$                            |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | 1.0  | μA    | $V_{DS} = 40\text{V}, V_{GS} = 0\text{V}$                          |
|                                 |                                      | —    | —     | 150  |       | $V_{DS} = 40\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | 100  | nA    | $V_{GS} = 20\text{V}$  |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | -100 |       | $V_{GS} = -20\text{V}$   |
| $R_G$                           | Internal Gate Resistance             | —    | 1.6   | —    | Ω     |  |

**Notes:**

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 120A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}, L = 0.046\text{mH}, R_G = 50\Omega, I_{AS} = 70\text{A}, V_{GS} = 10\text{V}$ .
- ④  $I_{SD} \leq 70\text{A}, di/dt \leq 1174\text{A}/\mu\text{s}, V_{DD} \leq V_{(BR)DSS}, T_J \leq 175^\circ\text{C}$ .
- ⑤ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

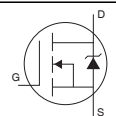
- ⑥  $C_{OSS}$  eff. (TR) is a fixed capacitance that gives the same charging time as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑦  $C_{OSS}$  eff. (ER) is a fixed capacitance that gives the same energy as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑧  $R_{\theta}$  is measured at  $T_J$  approximately  $90^\circ\text{C}$ .
- ⑨ This value determined from sample failure population, starting  $T_J = 25^\circ\text{C}, L = 0.046\text{mH}, R_G = 50\Omega, I_{AS} = 70\text{A}, V_{GS} = 10\text{V}$ .

**Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

| Symbol                     | Parameter                                     | Min. | Typ. | Max. | Units | Conditions   |
|----------------------------|---|------|------|------|-------|--|
| $g_{fs}$                   | Forward Transconductance                      | 269  | —    | —    | S     | $V_{DS} = 10V, I_D = 70A$  |
| $Q_g$                      | Total Gate Charge                             | —    | 62   | 93   | nC    | $I_D = 70A$<br>$V_{DS} = 20V$<br>$V_{GS} = 10V$ ⑤                      |
| $Q_{gs}$                   | Gate-to-Source Charge                         | —    | 16   | —    |       |  |
| $Q_{gd}$                   | Gate-to-Drain ("Miller") Charge               | —    | 20   | —    |       |  |
| $Q_{sync}$                 | Total Gate Charge Sync. ( $Q_g - Q_{gd}$ )    | —    | 42   | —    |       |  |
| $t_{d(on)}$                | Turn-On Delay Time                            | —    | 11   | —    | ns    | $V_{DD} = 20V$<br>$I_D = 30A$<br>$R_G = 2.7\Omega$<br>$V_{GS} = 10V$ ⑤ |
| $t_r$                      | Rise Time                                     | —    | 34   | —    |       |  |
| $t_{d(off)}$               | Turn-Off Delay Time                           | —    | 33   | —    |       |  |
| $t_f$                      | Fall Time                                     | —    | 23   | —    |       |  |
| $C_{iss}$                  | Input Capacitance                             | —    | 3183 | —    | pF    | $V_{GS} = 0V$<br>$V_{DS} = 25V$<br>$f = 1.0\text{ MHz}$ , See Fig. 5   |
| $C_{oss}$                  | Output Capacitance                            | —    | 475  | —    |       |  |
| $C_{riss}$                 | Reverse Transfer Capacitance                  | —    | 331  | —    |       |  |
| $C_{oss\text{ eff. (ER)}}$ | Effective Output Capacitance (Energy Related) | —    | 596  | —    |       |  |
| $C_{oss\text{ eff. (TR)}}$ | Effective Output Capacitance (Time Related)   | —    | 688  | —    |       |  |

**Diode Characteristics**

| Symbol    | Parameter                                 | Min. | Typ. | Max. | Units | Conditions   |
|-----------|---|------|------|------|-------|--|
| $I_S$     | Continuous Source Current<br>(Body Diode) | —    | —    | 120① | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode.            |
| $I_{SM}$  | Pulsed Source Current<br>(Body Diode) ②   | —    | —    | 492  |       |  |
| $V_{SD}$  | Diode Forward Voltage                     | —    | 0.9  | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 70A, V_{GS} = 0V$ ⑤                                 |
| $dv/dt$   | Peak Diode Recovery ④                     | —    | 7.6  | —    | V/ns  | $T_J = 175^\circ\text{C}, I_S = 70A, V_{DS} = 40V$                                 |
| $t_{rr}$  | Reverse Recovery Time                     | —    | 22   | —    | ns    | $T_J = 25^\circ\text{C}$ $V_R = 34V,$<br>$T_J = 125^\circ\text{C}$ $I_F = 70A$     |
| $Q_{rr}$  | Reverse Recovery Charge                   | —    | 15   | —    |       |  |
|           |   | —    | 15   | —    | nC    | $T_J = 25^\circ\text{C}$ $di/dt = 100A/\mu\text{s}$ ⑤<br>$T_J = 125^\circ\text{C}$ |
| $I_{RRM}$ | Reverse Recovery Current                  | —    | 1.0  | —    | A     | $T_J = 25^\circ\text{C}$   |



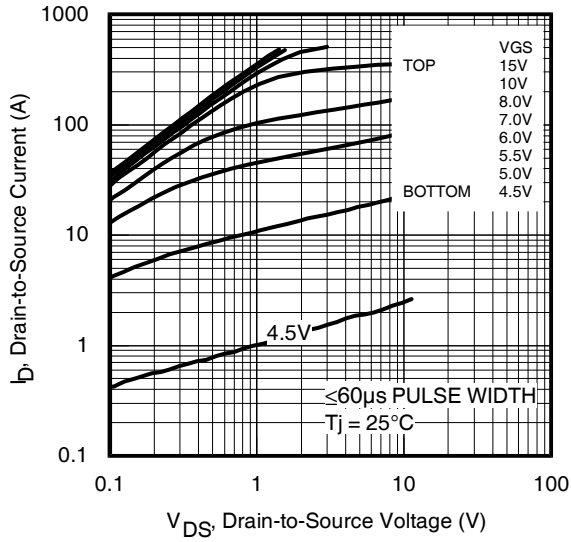


Fig 3. Typical Output Characteristics

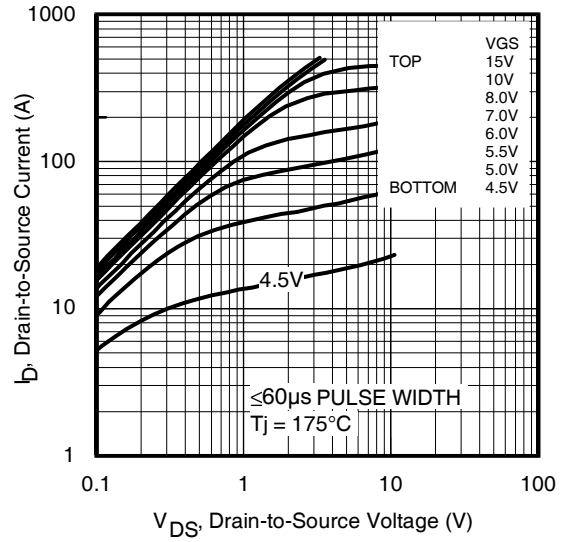


Fig 4. Typical Output Characteristics

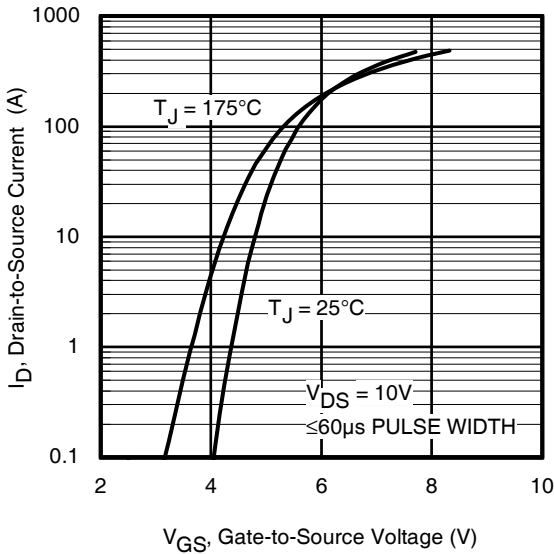


Fig 5. Typical Transfer Characteristics

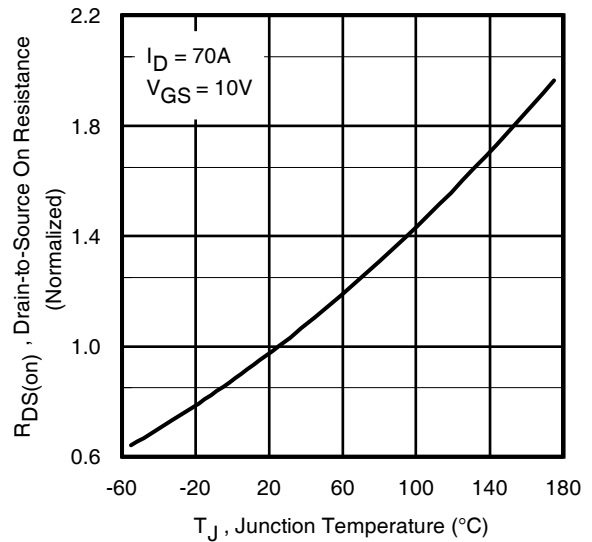


Fig 6. Normalized On-Resistance vs. Temperature

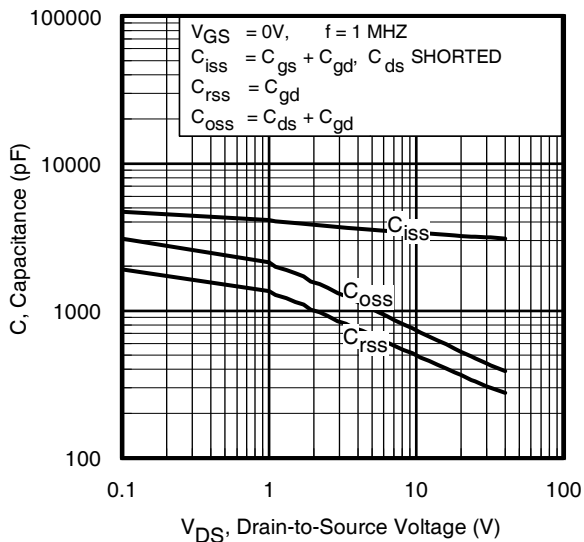


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

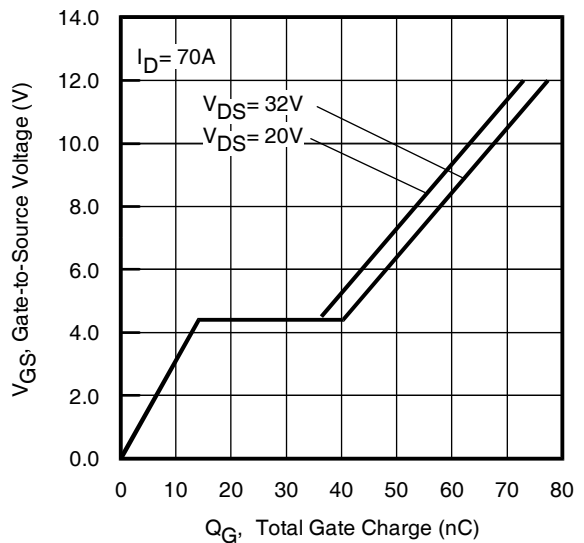
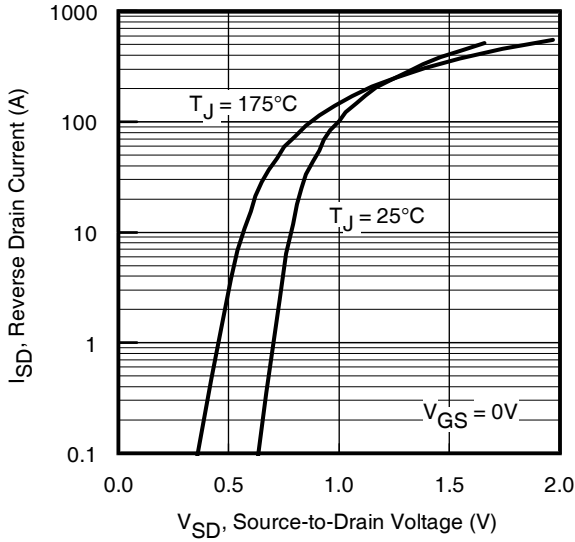
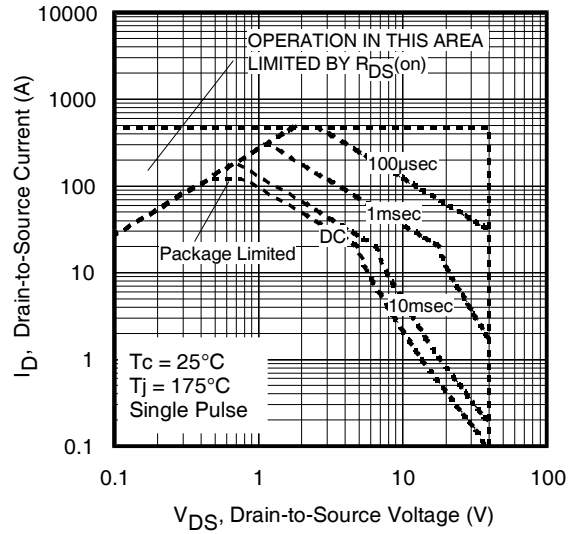


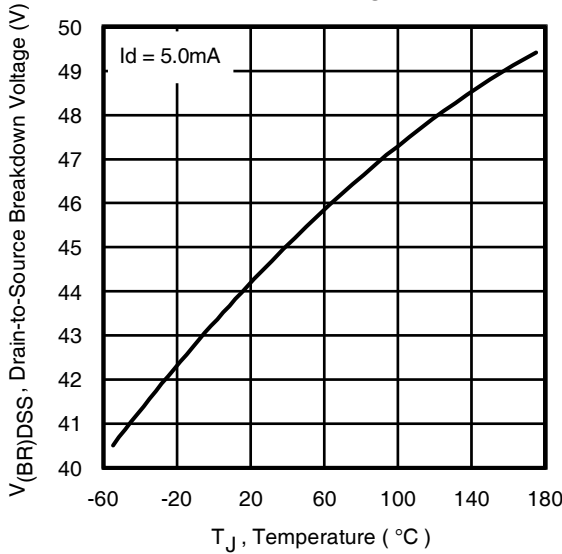
Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage



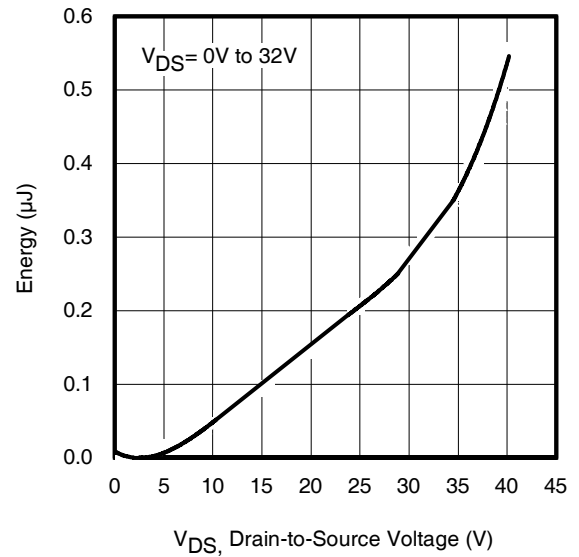
**Fig 9.** Typical Source-Drain Diode Forward Voltage



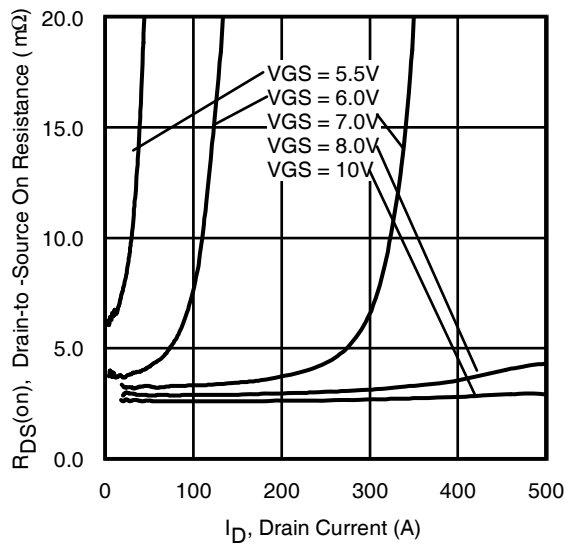
**Fig 10.** Maximum Safe Operating Area



**Fig 11.** Drain-to-Source Breakdown Voltage



**Fig 12.** Typical  $C_{OSS}$  Stored Energy



**Fig 13.** Typical On-Resistance vs. Drain Current

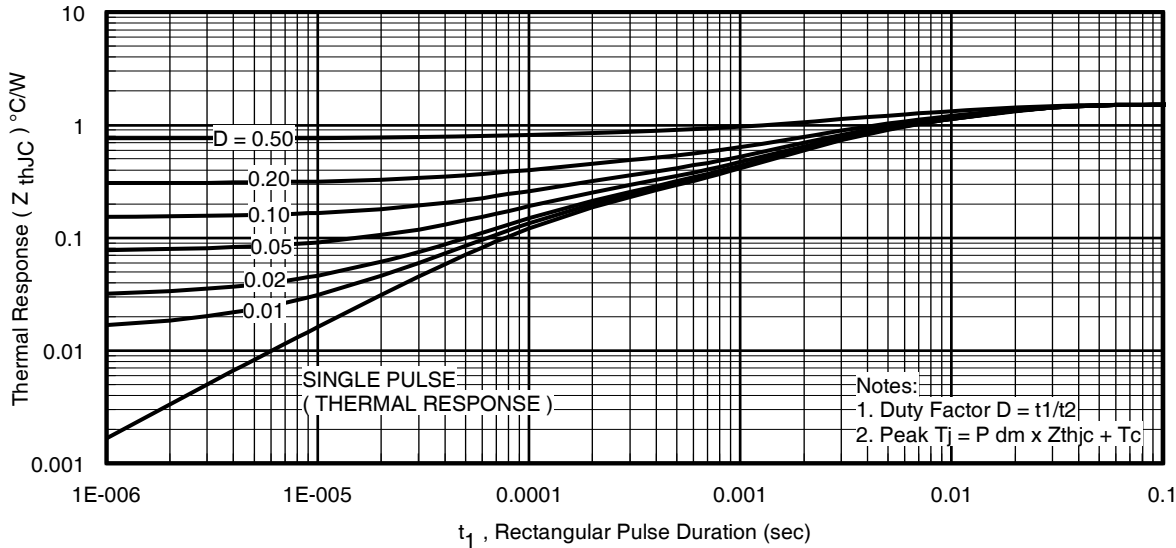


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

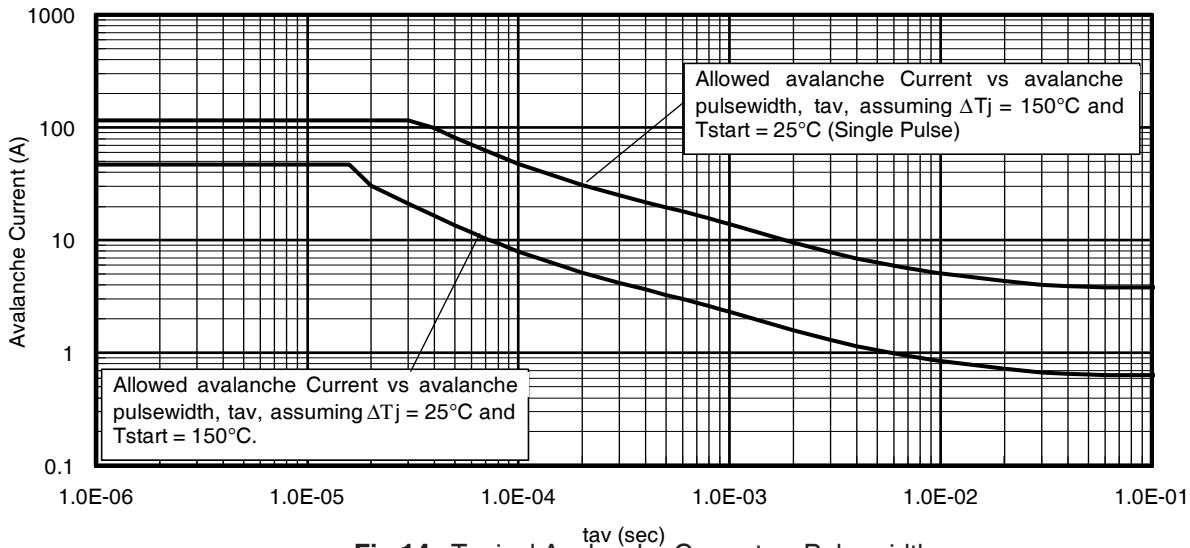


Fig 14. Typical Avalanche Current vs.Pulsewidth

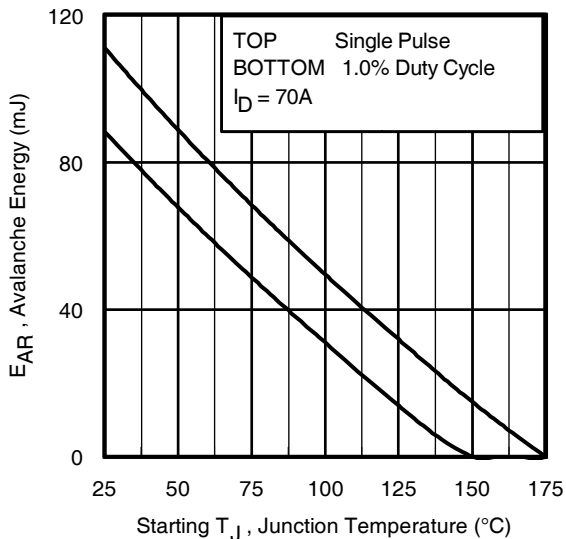


Fig 15. Maximum Avalanche Energy vs. Temperature

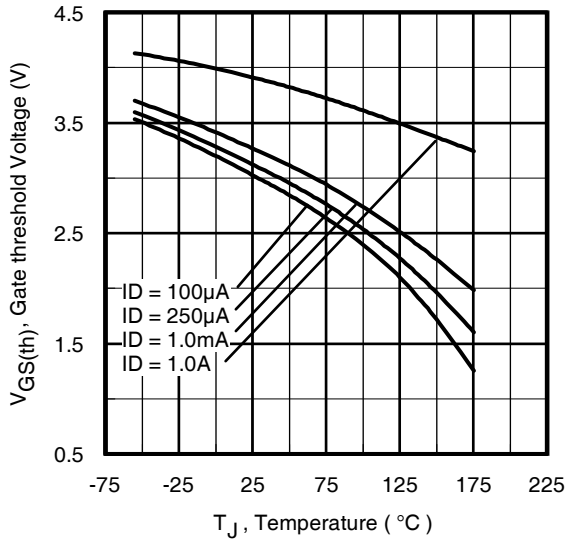
Notes on Repetitive Avalanche Curves , Figures 14, 15:  
(For further info, see AN-1005 at [www.irf.com](http://www.irf.com))

1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 22a, 22b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5.  $BV$  = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as  $25^\circ\text{C}$  in Figure 14, 15).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

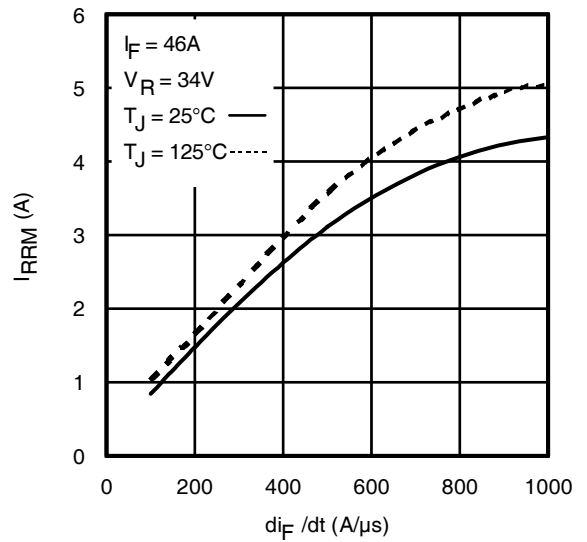
$$P_{D(ave)} = 1/2 ( 1.3 \cdot BV \cdot I_{av} ) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [ 1.3 \cdot BV \cdot Z_{th} ]$$

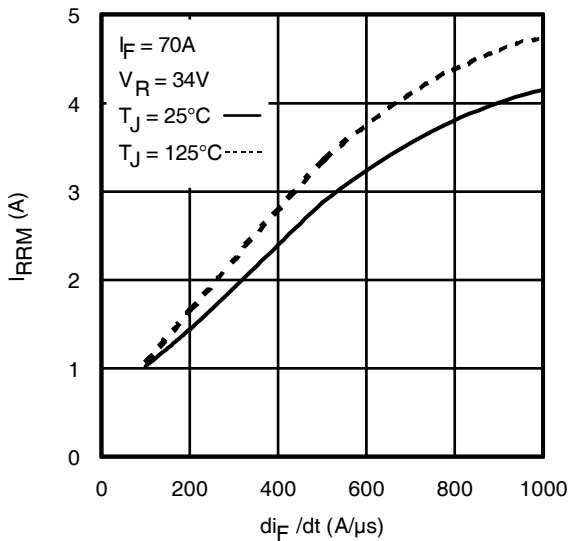
$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$



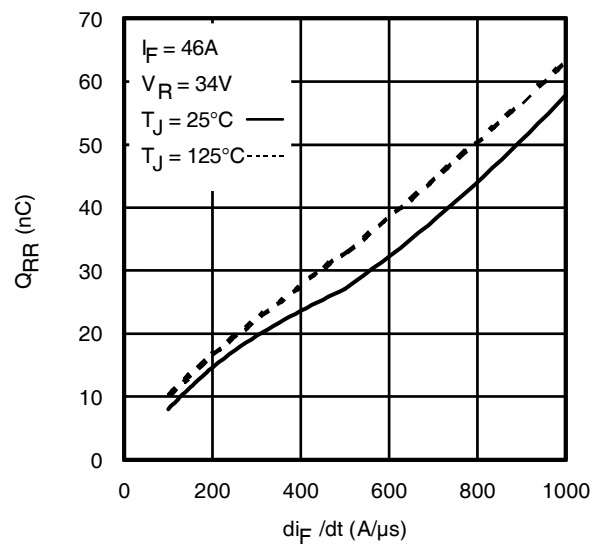
**Fig 16.** Threshold Voltage vs. Temperature



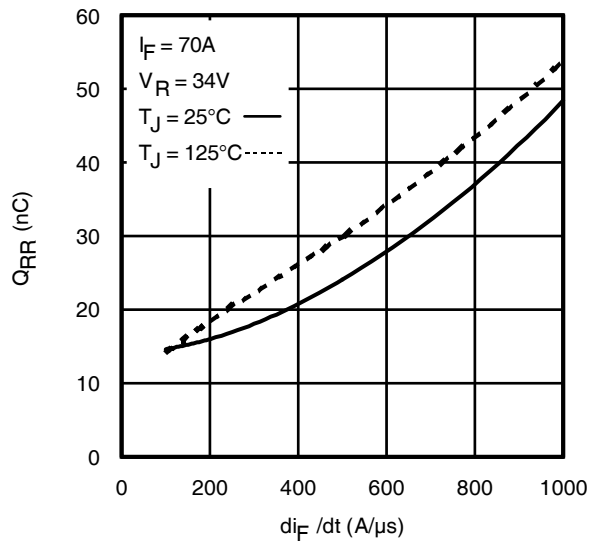
**Fig. 17 -** Typical Recovery Current vs.  $di_f/dt$



**Fig. 18 -** Typical Recovery Current vs.  $di_f/dt$



**Fig. 19 -** Typical Stored Charge vs.  $di_f/dt$



**Fig. 20 -** Typical Stored Charge vs.  $di_f/dt$

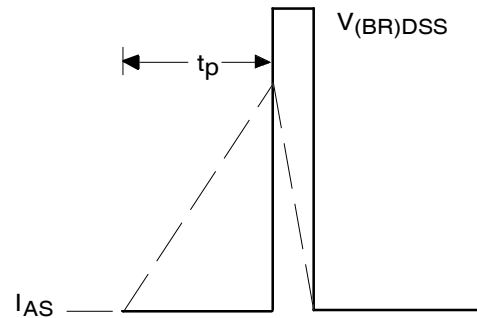


\*  $V_{GS} = 5V$  for Logic Level Devices

**Fig 21.** Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs



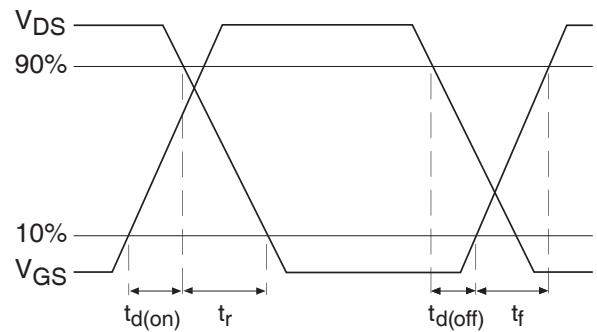
**Fig 22a.** Unclamped Inductive Test Circuit



**Fig 22b.** Unclamped Inductive Waveforms



**Fig 23a.** Switching Time Test Circuit



**Fig 23b.** Switching Time Waveforms



**Fig 24a.** Gate Charge Test Circuit

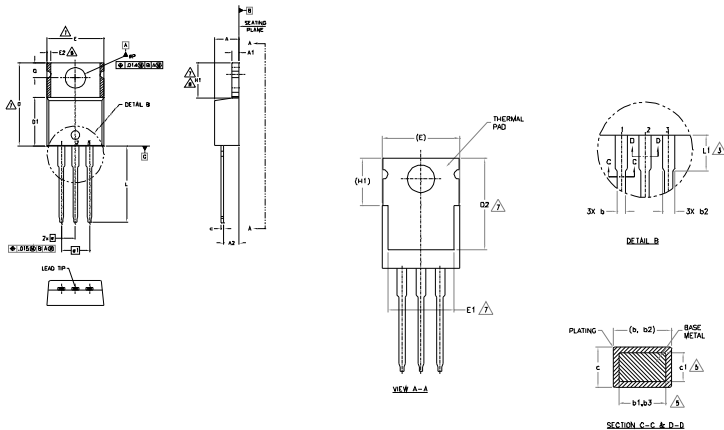


**Fig 24b.** Gate Charge Waveform



## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



- NOTES:
- 1.- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.
  - 2.- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
  - 3.- LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
  - 4.- DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
  - 5.- DIMENSION b1, b3 & c1 APPLY TO BASE METAL ONLY.
  - 6.- CONTROLLING DIMENSION : INCHES.
  - 7.- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
  - 8.- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SIMULATION IRREGULARITIES ARE ALLOWED.
  - 9.- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

| SYMBOL | DIMENSIONS           |       |                      |      | NOTES |
|--------|----------------------|-------|----------------------|------|-------|
|        | MILLIMETERS          |       | INCHES               |      |       |
|        | MIN.                 | MAX.  | MIN.                 | MAX. |       |
| A      | 3.56                 | 4.83  | .140                 | .190 |       |
| A1     | 0.51                 | 1.40  | .020                 | .055 |       |
| A2     | 2.03                 | 2.92  | .080                 | .115 |       |
| b      | 0.38                 | 1.01  | .015                 | .040 |       |
| b1     | 0.38                 | 0.97  | .015                 | .038 | 5     |
| b2     | 1.14                 | 1.78  | .045                 | .070 |       |
| b3     | 1.14                 | 1.73  | .045                 | .068 | 5     |
| c      | 0.36                 | 0.61  | .014                 | .024 |       |
| c1     | 0.36                 | 0.56  | .014                 | .022 | 5     |
| D      | 14.22                | 16.51 | .560                 | .650 | 4     |
| D1     | 8.38                 | 9.02  | .330                 | .355 |       |
| D2     | 11.68                | 12.88 | .460                 | .507 | 7     |
| E      | 9.65                 | 10.67 | .380                 | .420 | 4,7   |
| E1     | 6.86                 | 8.89  | .270                 | .350 | 7     |
| E2     | -                    | 0.76  | -                    | .030 | 8     |
| e      | 2.54 BSC<br>5.08 BSC |       | .100 BSC<br>.200 BSC |      |       |
| H1     | 5.84                 | 6.86  | .230                 | .270 | 7,8   |
| L      | 12.70                | 14.73 | .500                 | .580 |       |
| L1     | 3.56                 | 4.06  | .140                 | .160 | 3     |
| ØP     | 3.54                 | 4.08  | .139                 | .161 |       |
| Q      | 2.54                 | 3.42  | .100                 | .135 |       |

LEAD ASSIGNMENTS

HEXLET

HEXLET

1- GATE  
2- DRAIN  
3- SOURCE

IRBTL CopACK

1- GATE  
2- COLLECTOR  
3- EMITTER

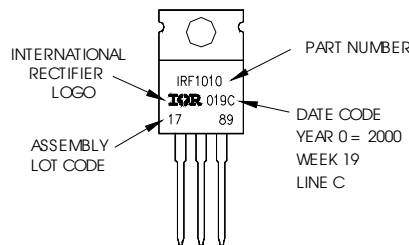
DIODES

1- ANODE  
2- CATHODE  
3- ANODE

## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
LOT CODE 1789  
ASSEMBLED ON WW 19, 2000  
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position  
indicates "Lead - Free"



TO-220AB packages are not recommended for Surface Mount Application.

**Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>**

### Qualification information†

|                            |                                   |                           |
|----------------------------|-----------------------------------|---------------------------|
| Qualification level        | Industrial††                      |                           |
|                            | (per JEDEC JESD47F††† guidelines) |                           |
| Moisture Sensitivity Level | TO-220AB                          | N/A                       |
|                            |                                   | (per JEDEC J-STD-020D†††) |
| RoHS compliant             | Yes                               |                           |

† Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/product-info/reliability/>

†† Higher qualification ratings may be available should the user have such requirements. Please contact your International Rectifier sales representative for further information: <http://www.irf.com/whoto-call/salesrep/>

††† Applicable version of JEDEC standard at the time of product release.

### Revision History

| Date      | Comment   |
|-----------|---|
| 9/11/2012 | Added Package limit on pg1,2 and updated Fig2 , Fig10 |

Data and specifications subject to change without notice.